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## PATENT ABSTRACTS OF JAPAN

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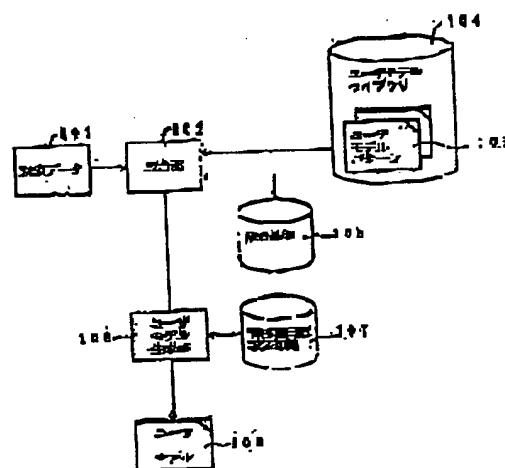
(21)Application number : 06-137591  
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## (54) METHOD AND DEVICE FOR GENERATING USER MODEL

## (57)Abstract

**PURPOSE:** To easily generate a user model by generating a user model pattern from plural similar patterns selected by referring to characteristic item value setting knowledge describing acquisition conditions for respective item values.

**CONSTITUTION:** A collating part 102 collates inputted objective data 101 with each user model pattern 103 in a user model library 104 and calculates the degrees of similarity of respective user model patterns based upon a collation reference 105. Then the collating part 102 mutually compares the degrees of similarity of respective patterns and selects a pattern having the degree of highest degree of similarity and a user model pattern having the degree of similarity whose difference from the maximum degree of similarity is included within an allowable error range. A user model generating part 106 acts up the item values of respective characteristic items based upon the item value of the user model pattern selected by the collating part 102 by the use of characteristic item value setting knowledge 107 describing knowledge for preparing one item value from plural characteristic item values and overwrites the value of the object data 101 to generate a user model 108.



## LEGAL STATUS

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